E5515C-08B

# SERVICE NOTE

Supersedes: E5515C-08A

E5515C Wireless Communications Test Set (8960 Series)

Serial Numbers: ALL

Power Measurement Accuracy Degradation Requires Replacement of RF Interface (Includes Thermal Power Detector and Amplifier Gain Stage Defects

**Parts Required:** 

P/N Description Qty.

E5515-61892 RFIO Repair Kit 1

### ADMINISTRATIVE INFORMATION

SERVICE NOTE CLASSIFICATION:				
MODIFICATION RECOMMENDED				
ACTION CATEGORY:	XX ON SPECIFIED FAILURE [[]] AGREEABLE TIME	STANDARDS  LABOR: 2.0 Hours		
LOCATION CATEGORY:	[[]] CUSTOMER INSTALLABLE XX ON-SITE XX SERVICE CENTER [[]] CHANNEL PARTNER	SERVICE XX RETURN INVENTORY: [[]] SCRAP [[]] SEE TEXT	USED XX RETURN PARTS: [[]] SCRAP [[]] SEE TEXT	
AVAILABILITY: PRODUCT'S SUPPORT LIFE NO CHARGE AVAILABLE UNTIL: 30 OCTOBER 2010				
AUTHOR: SW PRODUCT LINE: 13				
ADDITIONAL INFORMATION: PL13 is setting up an RFIO refurbishment kit – this will be available approximately Feb 2010.				

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### **Situation:**

The Test Set's RF Interface may require replacement to resolve inaccurate power measurements. Two separate failure mechanisms can occur which requires separate detection methods:

### • Digital Average (DAP) & Thermal Power measurements:

DAP is used in cdma2000 and 1xEV-DO applications. Thermal Power is used in WCDMA applications. Both Test Applications (TA) and Lab Applications (LA) may be affected (Only specific TAs & LAs have DAP or Thermal Power measurement capability. Refer to the <u>table</u> below). A faulty thermal power detector, with an RF signal applied to the RF IN/OUT connector, will display measured power above or below the level of the input signal. A second failure mode, which can be used for fault detection, occurs with no signal applied to the RF IN/OUT connector. <u>Procedure 1</u>, which detects the latter failure mode, should be used to determine if the RF Interface should be replaced due to a defective thermal power detector.

Test Application	Technology	Power Measurement
E1962B	cdma2000	DAP
E1963A	W-CDMA	Thermal Power
E1966A	1xEV-DO	DAP
E1985B	W-CDMA	Thermal Power
E1985C	cdma2000	DAP
E1985E	cdma2000, 1xEV-DO	DAP
E1987A	cdma2000, 1xEV-DO, W-CDMA	DAP and Thermal
Lab Application	Technology	Power Measurement
E6702C	cdma2000	DAP
E6703F	W-CDMA	Thermal Power
E6706C	1xEV-DO	DAP
E6785F	W-CDMA	Thermal Power

### • Peak Power or Fast Detector measurements:

This measurement is used in IS-95 (CDMA), GSM, TDMA, and AMPS applications. Both Test Applications (TA) and Lab Applications (LA) may be affected. Defective amplifiers will cause power measurement readings to drift from 1-5 dB over time. Procedure 2, which detects this amplifier drift, should be used to determine if the RF Interface should be replaced.

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### **Solution/Action:**

Use the following two procedures to determine if the RFIO (RF Interface) should be replaced. The RFIO should be replaced if **either** procedure fails.

# **Procedure 1:** Manual procedure for Digital Average (DAP) & Thermal Power Detector Verification (No external test equipment is required)

Allow the Test Set to warm up for 30 minutes before proceeding:

- Ensure that no RF signal is applied to the RF IN/OUT connector
- Set the RF IN/OUT Amplitude Offset State to "OFF" (from the **SYSTEM CONFIG** screen)
- Press the "CALL SETUP" key
- Press the F7 "Cell Power" key, then Press the "OFF" key
- Press the "Measurement Selection" key
- Select:
  - "Digital Average Power" for cdma2000 or 1xEV-DO
  - "Thermal Power" for WCDMA
- Press:
  - The F1 "**Digital Average Power Setup**" key for cdma2000 or 1xEV-DO
  - The F1 "Thermal Power Setup" key for WCDMA
- Select "Multi-Measurement Count", then set value to 100
- Select "Trigger Arm", then select "Single"
- Press the "START SINGLE" key

Pass condition: Displayed value ≤ -32 dBm Fail condition: Displayed value > -32 dBm Execution time: Approximately 20 seconds

Turn the "RF IN/OUT Amptd Offset" state to "On"

## **Procedure 2: Manual procedure for Amplifier Gain Stage Drift Verification**

Verify the performance of the RF Interface using the procedure below. Replace it if it does not meet specifications (refer to the *Specifications Table* for specific values). Verify that the replacement RF Interface also meets these specifications. Use proper anti-static protection to remove and replace this assembly. Upgrade of the Test Application(s) may be required.

### Required Test Equipment:

Instrument	Critical Specifications	<b>Recommended Agilent Model</b>
Signal Generator	850 MHz Frequency	ESG Series
	>+10 dBm maximum power	
Power Meter	±0.02 dB Instrument Accuracy	EPM Series or 438A
Power Sensor	850 MHz Frequency	E-Series or 8482A
	>+14 dBm maximum input	
	±4% linearity	
Power Splitter	850 MHz frequency	11667A
	±0.05 dB tracking	

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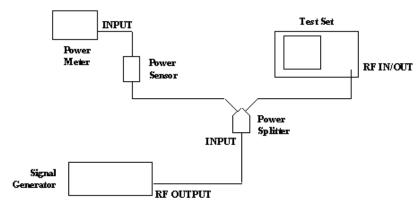
Additional Equipment:

Male-to-Male Type-N adapter (qty 1)

2-3 foot Type-N RF coaxial cable (qty 1)

### Procedure:

- 1. If necessary, enter the power sensor calibration factors into the power meter.
- 2. Zero and calibrate the power meter and power sensor.
- 3. Connect the equipment as follows:



- a. Connect the signal generator to the input of the power splitter with the coaxial cable.
- b. Connect one arm of the power splitter to the Test Set RF IN/OUT connector <u>directly</u> through a Male-to-Male Type-N adapter.
- c. Connect the power sensor <u>directly</u> to the other arm of the power splitter.
- 4. On the power meter, set the power sensor calibration factor for 850 MHz.
- 5. On the signal generator set the frequency to 850 MHz.
- 6. On the Test Set:
  - a. Perform a full preset (SHIFT, Preset).
  - b. For E1960A Test Application:
    - i. On Call Parms Menu 1 set Cell Power to Off.
    - ii. On Call Parms Menu 3 set Receiver Control to Manual and Manual Freq to 850 MHz.
    - iii. Push the MEASUREMENT SELECTION key and select Transmit Power.
  - c. For E1961A Test Application:
    - i. On Call Control Menu set Active Cell to CW
    - ii. On Control Parms Menu set Cell Power to Off.
    - iii. On Control Parms Menu select Receiver Control and set Expected CW Power to each level specified in the *Results Table*. Set Measurement Frequency and Uplink Frequency to 850 MHz.
    - iv. Push the MEASUREMENT SELECTION key and select Analog Transmit Power.
  - d. For E1962B Test Application:
    - i. On the Call Control Menu set Sys Type to AMPS
    - ii. On Call Parms Menu 1 set Cell Power to Off.
    - iii. On Call Parms Menu 3 set Rcvr Power Ctrl to Manual and Meas Frequency to 850 MHz.
    - iv. Push the MEASUREMENT SELECTION key and select Analog Transmit
- 7. For both level settings in the *Results Table* below, do the following:
  - a. On the Test Set, set the Expected Power (E1960A) **or** Receiver Power (E1962B) to the level being tested. Note: For E1961A the Expected CW Power is set in step 6c-iii.
  - b. On the signal generator, adjust the output so that the power meter displays the level shown in the *Results Table* below. This compensates for splitter and cable losses (approx 6dB).

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c. Subtract the reading of the power meter from the reading of the Test Set and enter the calculated value in the *Results Table*. The calculated value should not exceed the values listed in the *Specifications Table* (below):

Specifications Table

Test Application	RF Power (CW) Measurement Accuracy Specification
E1960A (GSM)	±0.27 dB
E1961A (AMPS/136)	±0.27 dB
E1962B (cdma2000/IS-95/AMPS)	±0.32 dB
E1963A (W-CDMA)	Not Applicable
E1964A (GPRS)	Not Applicable

Test Set Serial Number:	
RF Interface Part Number:	

### Results Table

Frequency	Level Setting (dBm)		
	+ 4.0	-20.0	
850 MHz (initial performance)			
850 MHz (after replacement)			

**NOTE:** Include a copy of these results with the defective RF Interface being returned **OR** E-mail them to spokane\_service@agilent.com.